

**Search Notes (continued)**

Application/Control No.

10/780,990

Examiner

Sun J. Lin

Applicant(s)/Patent under  
Reexamination

BENTLEY ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	11	2/26/2007	JSL
716	15	2/26/2007	JSL
716	1	2/26/2007	JSL
700	121	2/26/2007	JSL
700	97	2/26/2007	JSL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
716	11	2/26/2007	JSL
716	1,15	2/26/2007	JSL
700	121	2/26/2007	JSL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST [USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB]	2/26/2007	JSL